

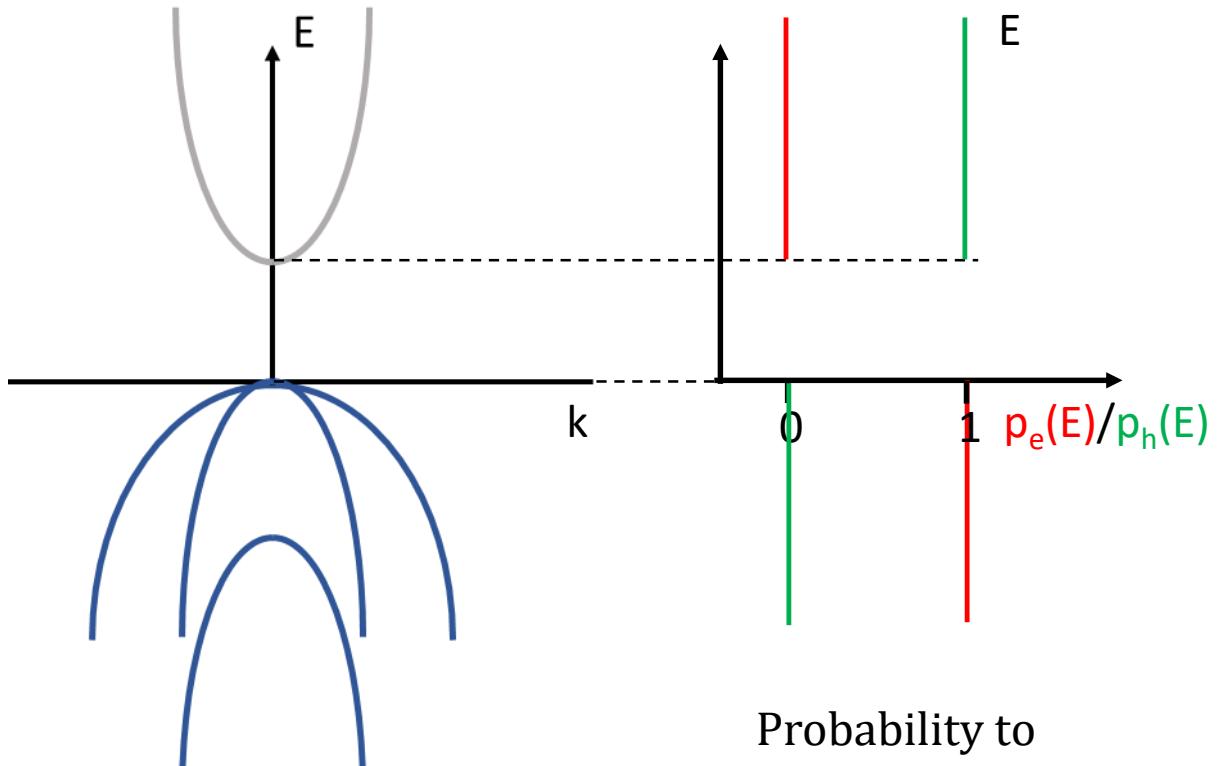
# Class 04

## Charge density in intrinsic semiconductors

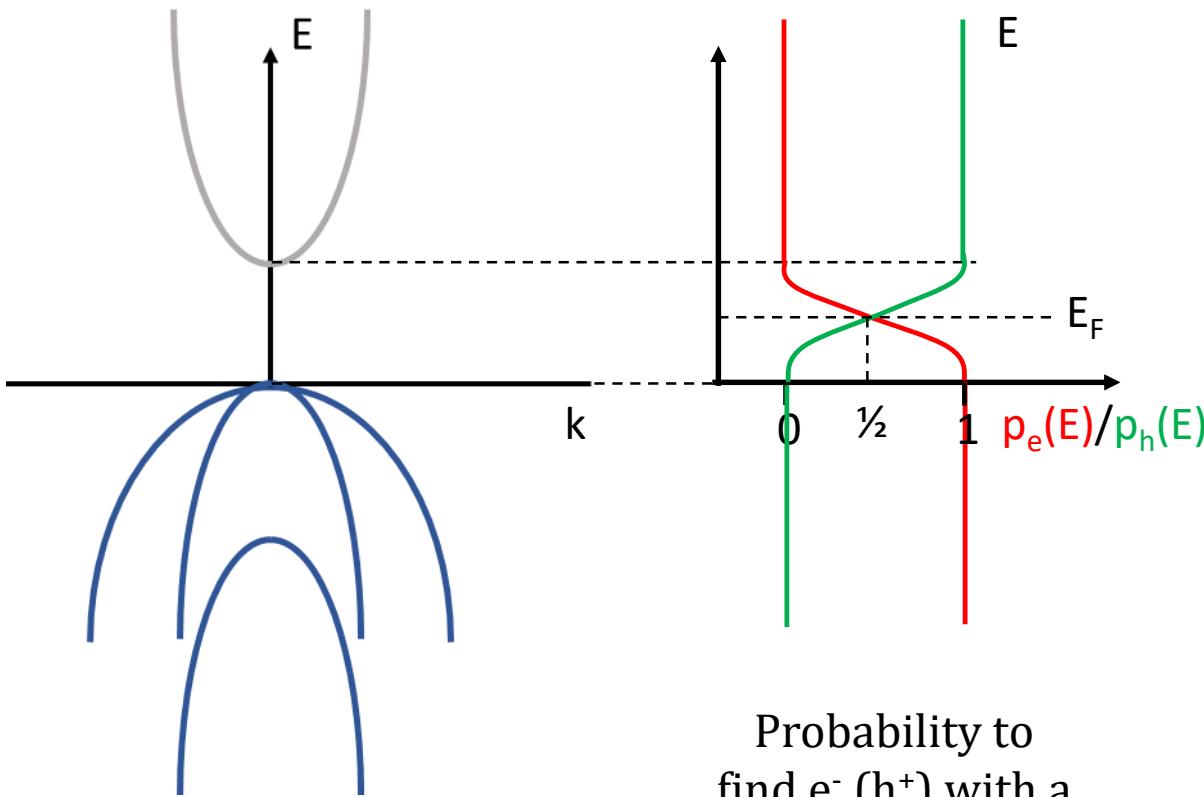
25.02.2025

- Fermi-Dirac distribution and Fermi energy
- Carrier Statistics
- Charge density engineering
  - Effect of band gap
  - Effect of dimensionality
  - Effect of temperature
  - Effect of electric field
  - Effect of confinement

# Carrier Statistics



Probability to  
find  $e^-$  ( $h^+$ ) with a  
certain energy at  
 $T = 0K$



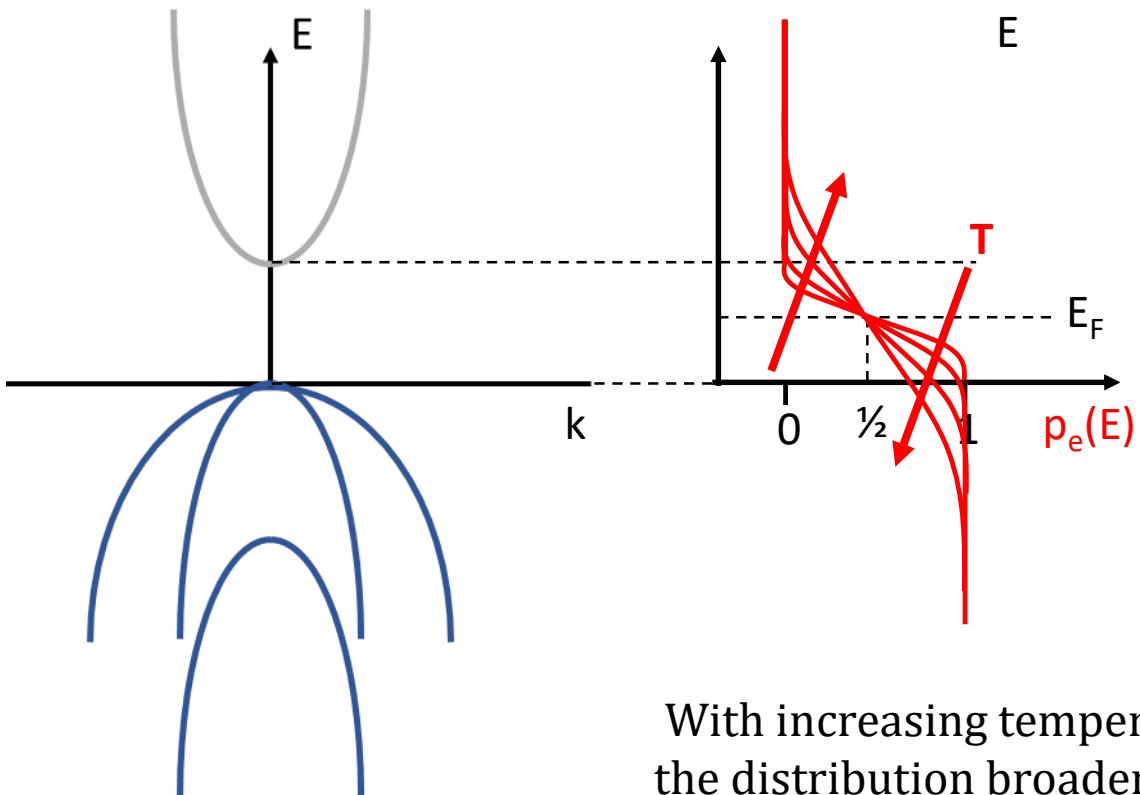
## Fermi-Dirac distribution

$$f_e(E) = \frac{1}{\exp\left(\frac{E-E_F}{kT}\right) + 1} .$$

$$f_h(E) = 1 - \frac{1}{\exp\left(\frac{E-E_F}{kT}\right) + 1} = \frac{1}{\exp\left(-\frac{E-E_F}{kT}\right) + 1}$$

Can you give the definition of  $E_F$  starting from the general expression of FD distribution?

Please note that by definition,  $E_F$  represents the chemical potential of the crystal.



With increasing temperature the distribution broadens and the probability to find  $e^- (h^+)$  in the conduction (valence) band is higher than 0

## Fermi-Dirac distribution

$$f_e(E) = \frac{1}{\exp\left(\frac{E-E_F}{kT}\right) + 1} .$$

$$f_h(E) = 1 - \frac{1}{\exp\left(\frac{E-E_F}{kT}\right) + 1} = \frac{1}{\exp\left(-\frac{E-E_F}{kT}\right) + 1}$$

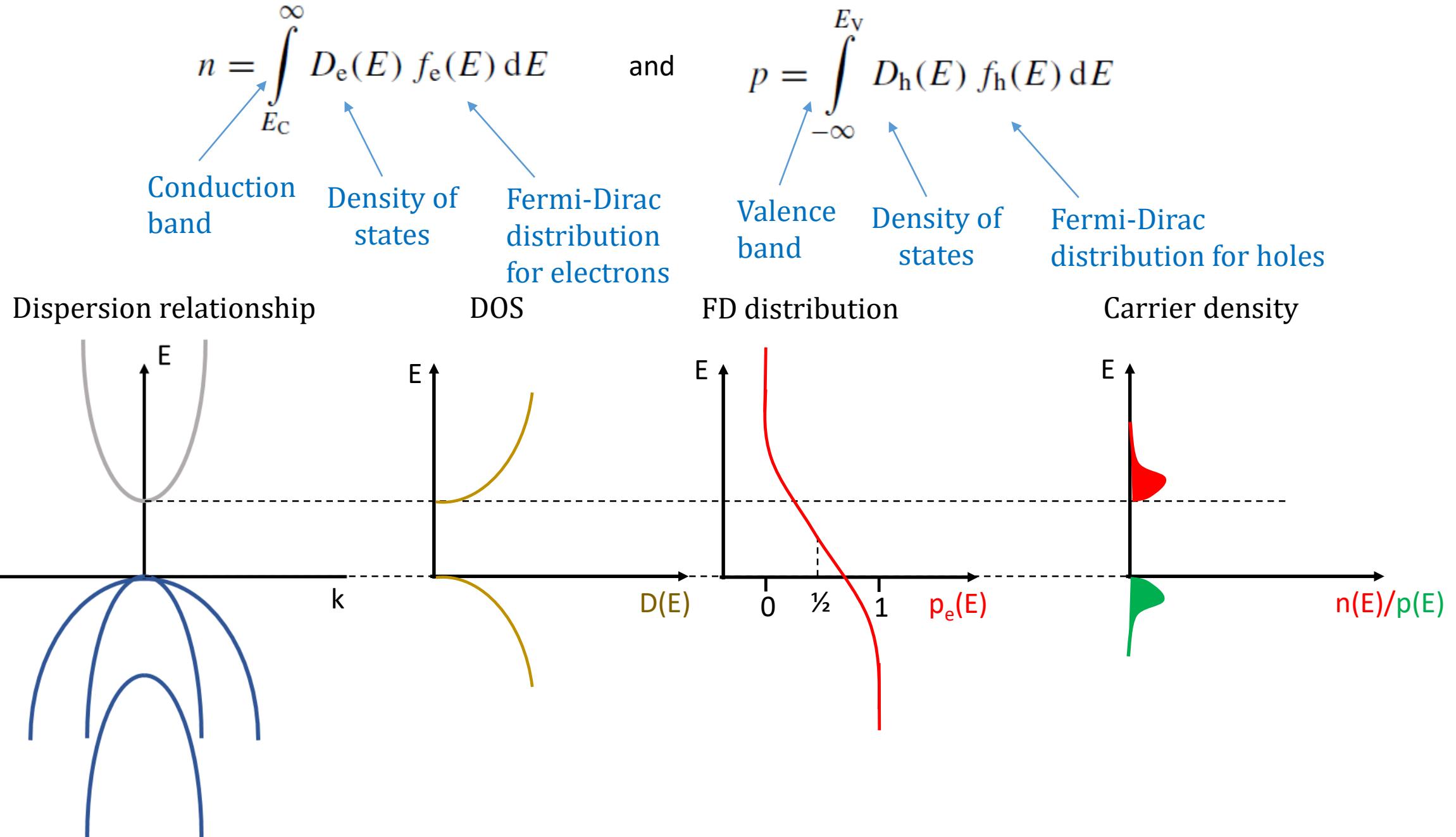
where:

$$f_e(E_F) = f_h(E_F) = \frac{1}{2}$$

$E_F$  is the Fermi energy

Please note that by definition,  $E_F$  represents the chemical potential of the crystal.

# Carrier density



## Analytical solution to the charge density integral

$$n = \int_{E_C}^{\infty} D_e(E) f_e(E) dE$$

where:

$$D_e^{3D}(E) = \frac{1}{2\pi^2} \left( \frac{2m_{d,e}}{\hbar^2} \right)^{3/2} \sqrt{E - E_C}, \quad E > E_C$$

$$D_h^{3D}(E) = \frac{1}{2\pi^2} \left( \frac{2m_{d,h}}{\hbar^2} \right)^{3/2} \sqrt{E_V - E}, \quad E < E_V.$$

$$f_e(E) = \frac{1}{\exp\left(\frac{E-E_F}{kT}\right) + 1}.$$

### Boltzmann approximation

$$\text{If } E - E_F \gg kT,$$



$$f_e(E) \cong \exp\left(-\frac{E - E_F}{kT}\right).$$

$$\rightarrow \begin{cases} n = 2 \left( \frac{m_e k T}{2\pi \hbar^2} \right)^{3/2} \exp\left(\frac{E_F - E_C}{kT}\right) = N_C \exp\left(\frac{E_F - E_C}{kT}\right) \\ p = 2 \left( \frac{m_h k T}{2\pi \hbar^2} \right)^{3/2} \exp\left(-\frac{E_F - E_V}{kT}\right) = N_V \exp\left(-\frac{E_F - E_V}{kT}\right) \end{cases}$$

where:  $N_C = 2 \left( \frac{m_e k T}{2\pi \hbar^2} \right)^{3/2}$        $N_V = 2 \left( \frac{m_h k T}{2\pi \hbar^2} \right)^{3/2}$

$N_C$  ( $N_V$ ) is called conduction (valence) band edge density of states

## $E_F$ for intrinsic semiconductors

$$n = 2 \left( \frac{m_e k T}{2\pi \hbar^2} \right)^{3/2} \exp \left( \frac{E_F - E_C}{k T} \right) = N_C \exp \left( \frac{E_F - E_C}{k T} \right) .$$

$$p = 2 \left( \frac{m_h k T}{2\pi \hbar^2} \right)^{3/2} \exp \left( -\frac{E_F - E_V}{k T} \right) = N_V \exp \left( -\frac{E_F - E_V}{k T} \right) .$$

+

**ELECTRONEUTRALITY CONDITION**  
 $n = p$  for intrinsic semiconductors

where:  $N_C = 2 \left( \frac{m_e k T}{2\pi \hbar^2} \right)^{3/2}$        $N_V = 2 \left( \frac{m_h k T}{2\pi \hbar^2} \right)^{3/2}$ ,

---

$$N_C \exp \left( \frac{E_F - E_C}{k T} \right) = N_V \exp \left( \frac{E_V - E_F}{k T} \right)$$

$E_i$  is the midgap energy

$$\frac{E_F - E_C - E_V + E_F}{k T} = \ln \frac{N_V}{N_C}$$

$$\frac{2E_F - 2E_i}{k T} = -\frac{3}{2} \ln \frac{m_e^*}{m_h^*}$$

$$E_F = E_i - \frac{3}{4} k T * \ln \frac{m_e^*}{m_h^*}$$

## Mass action law

### ELECTRONEUTRALITY CONDITION

$-n + p = 0$  (for intrinsic semiconductors)

$$n = p$$

$n^*p = n_i^2$  for all the non-degenerate semiconductors

Intrinsic  
electron(hole)  
density

$$n_i = p_i = \sqrt{N_V N_C} \exp\left(-\frac{E_g}{2kT}\right)$$

$n_i$  depends on:

- The temperature
- The bandgap
- The (conduction and valence band) DOS

$n_i$  does not depend on:

- Fermi energy

And it is therefore valid also for doped semiconductors

## Recap equations

$$n = \int_{E_C}^{\infty} D_e(E) f_e(E) dE$$

$$n = 2 \left( \frac{m_e k T}{2\pi \hbar^2} \right)^{3/2} \exp \left( \frac{E_F - E_C}{k T} \right) = N_C \exp \left( \frac{E_F - E_C}{k T} \right)$$

$$N_C = 2 \left( \frac{m_e k T}{2\pi \hbar^2} \right)^{3/2}$$

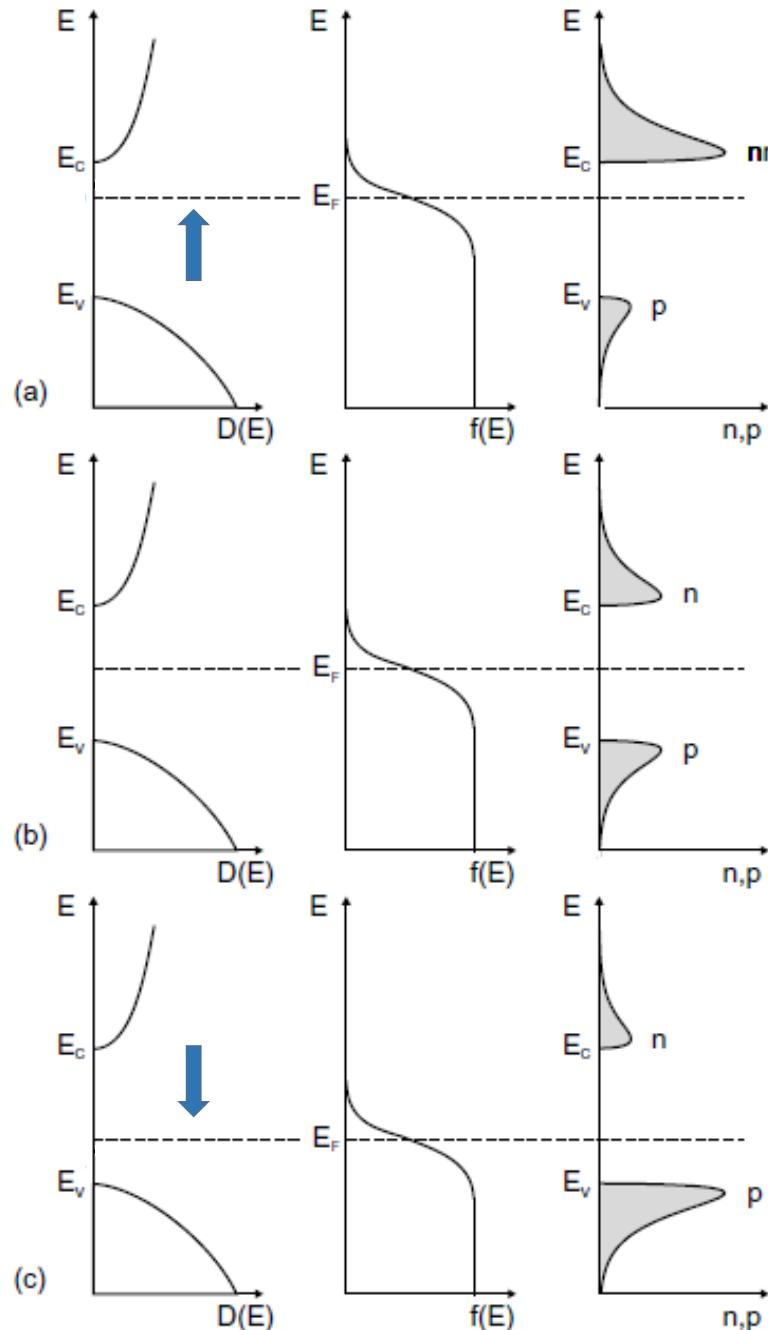
$$E_F = E_i - \frac{3}{4} k T * \ln \frac{m_e^*}{m_h^*}$$

$$n_i = p_i = \sqrt{N_V N_C} \exp \left( -\frac{E_g}{2kT} \right)$$

$$n_i = p_i = \sqrt{N_V N_C} \exp\left(-\frac{E_g}{2kT}\right)$$

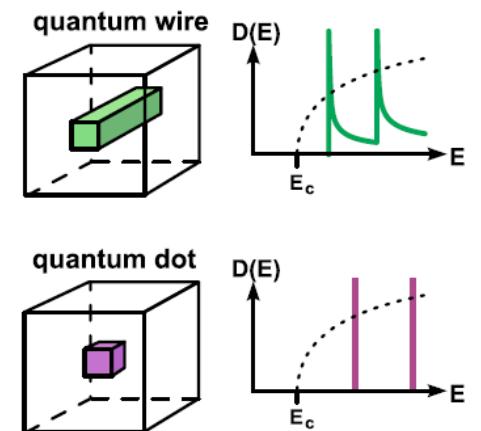
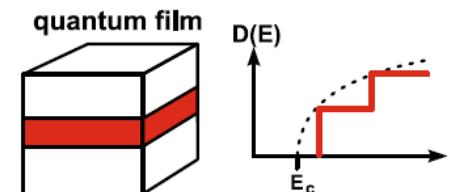
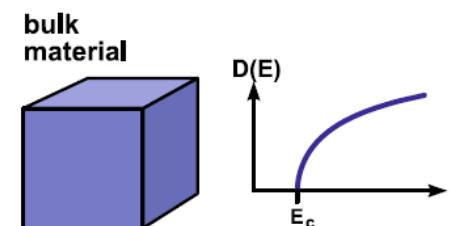
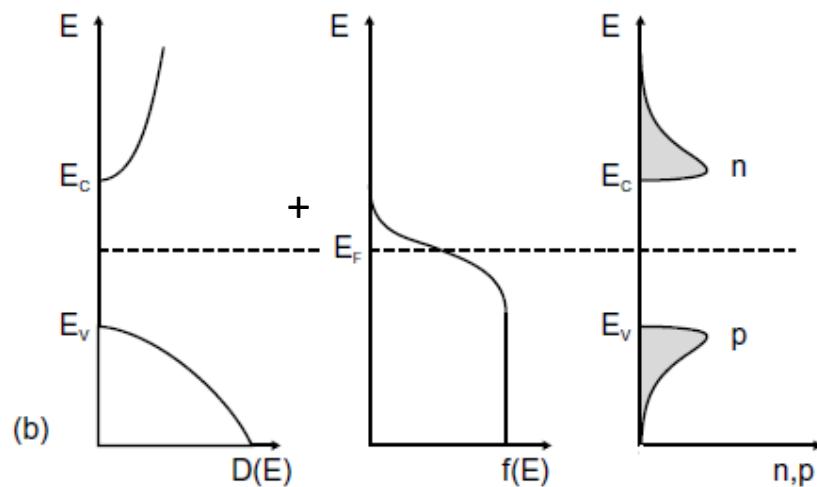
	$E_g$ (eV)	$n_i$ (cm $^{-3}$ )
InSb	0.18	$1.6 \times 10^{16}$
InAs	0.36	$8.6 \times 10^{14}$
Ge	0.67	$2.4 \times 10^{13}$
Si	1.124	$1.0 \times 10^{10}$
GaAs	1.43	$1.8 \times 10^6$
GaP	2.26	$2.7 \times 10^0$
GaN	3.3	$\ll 1$

$$n = N_C \exp\left(\frac{E_F - E_C}{kT}\right)$$



# Impact of **dimensionality** on the carrier density

$$n = \int_{E_C}^{\infty} D_e(E) f_e(E) dE, \quad p = \int_{-\infty}^{E_V} D_h(E) f_h(E) dE.$$



## Impact of **temperature** on the carrier density

$$n_i = p_i = \sqrt{N_V N_C} \exp\left(-\frac{E_g}{2kT}\right)$$

The bandgap also varies with T due to a different electron-phonon interaction and the variation of the interatomic distance.

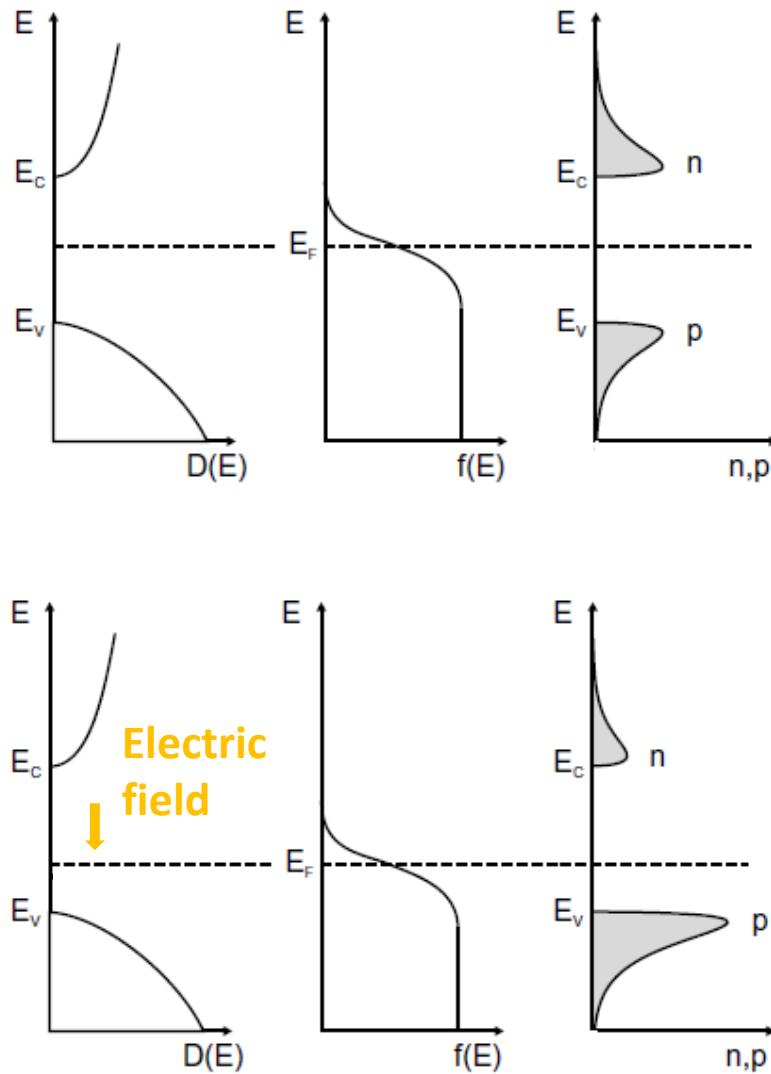
How does the band gap change with increasing T?

- Larger BG
- Same BG (negligible effect)
- Smaller BG

Which factor is dominant for the  $n_i$ ?

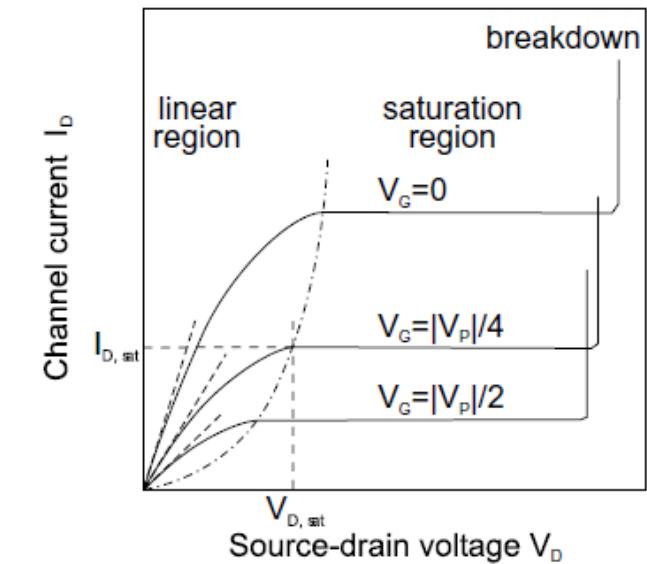
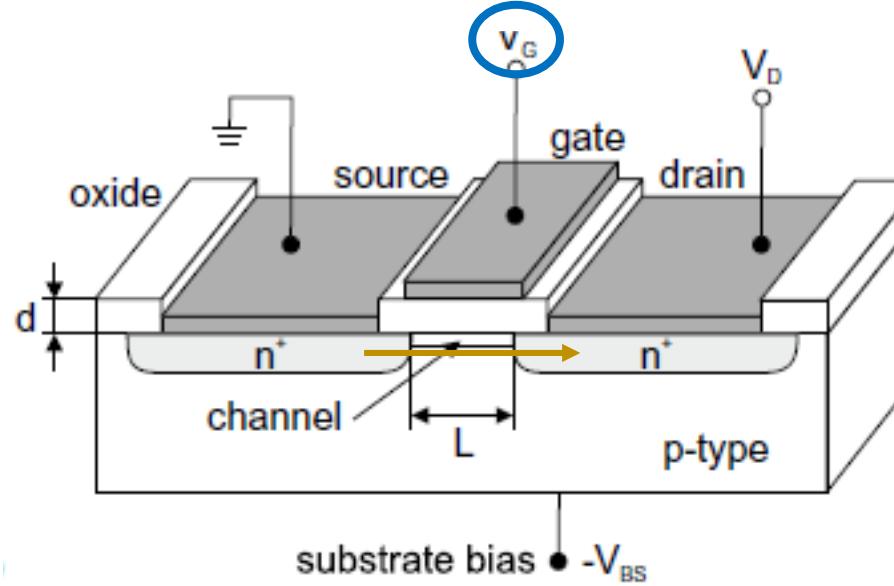
To be solved in class  
5 minutes

# Impact of **electric field** on the carrier density

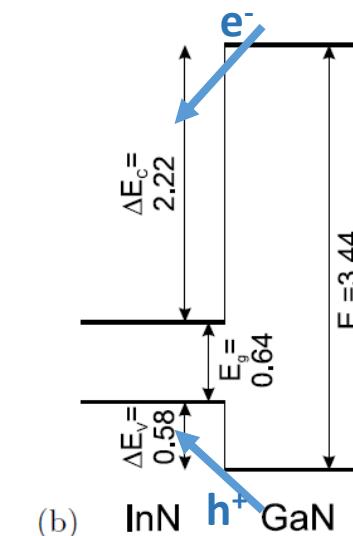
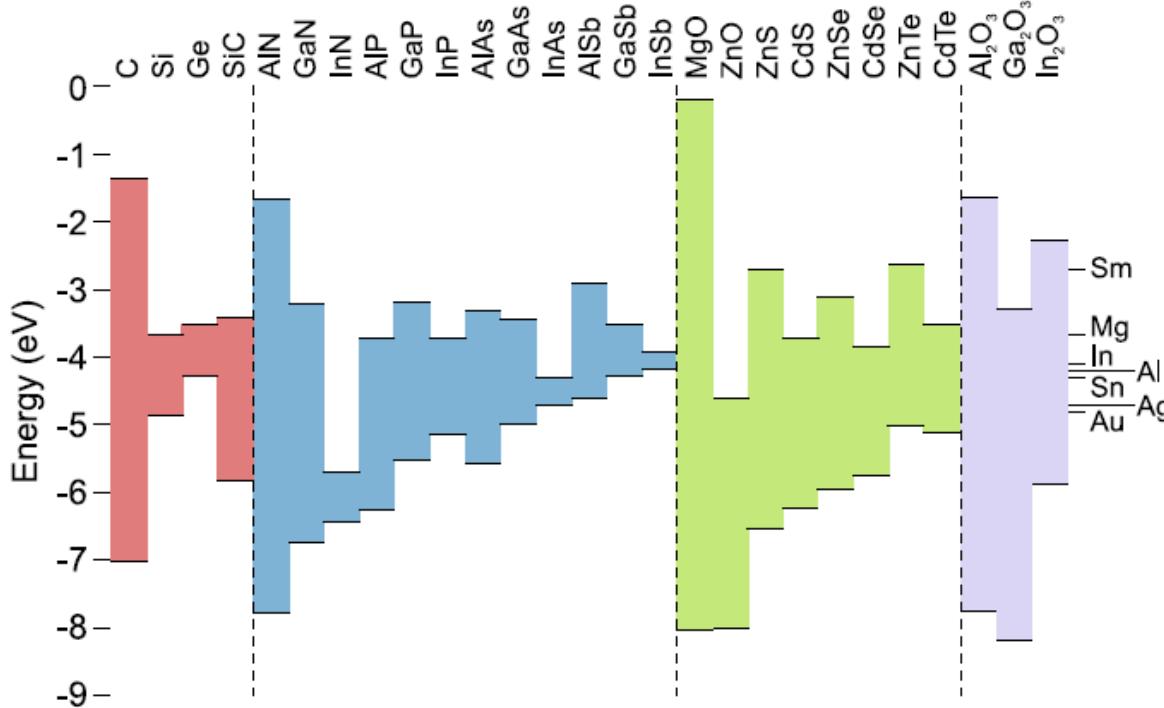


**Electronic switch: Field effect transistor (FET)**

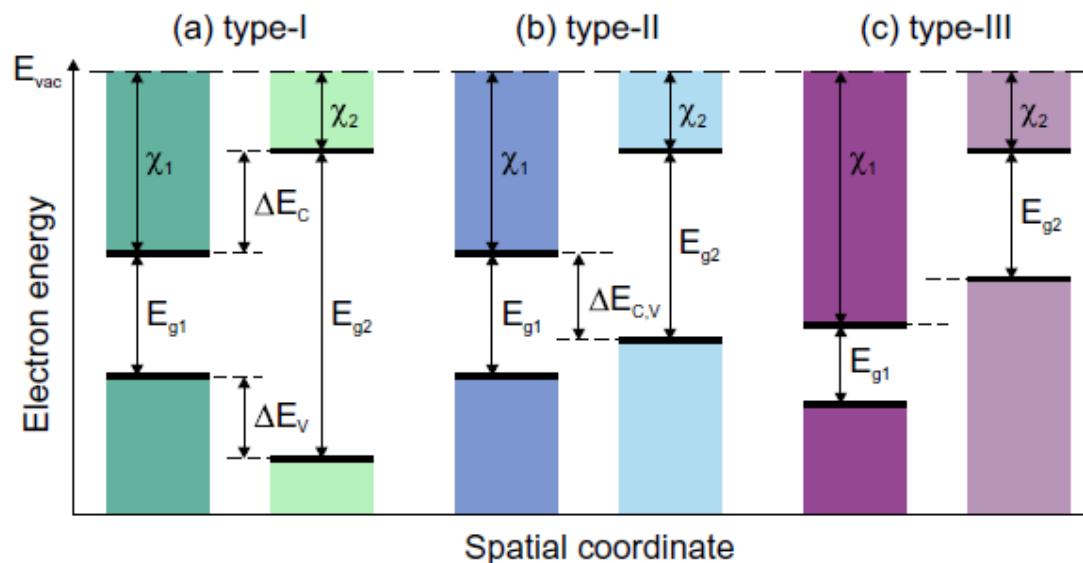
**Gate voltage → Controlling the Fermi energy into the «channel»**



# Impact of confinement and heterostructures on the carrier density



(b) InN  $h^+$  GaN

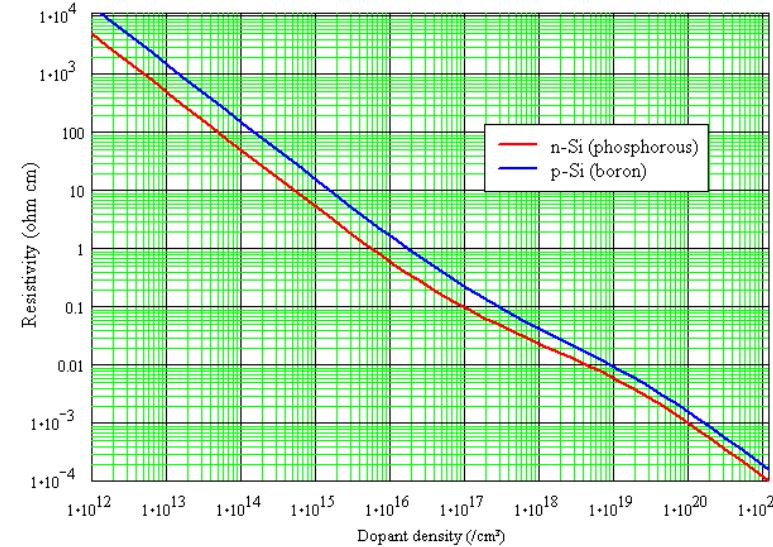
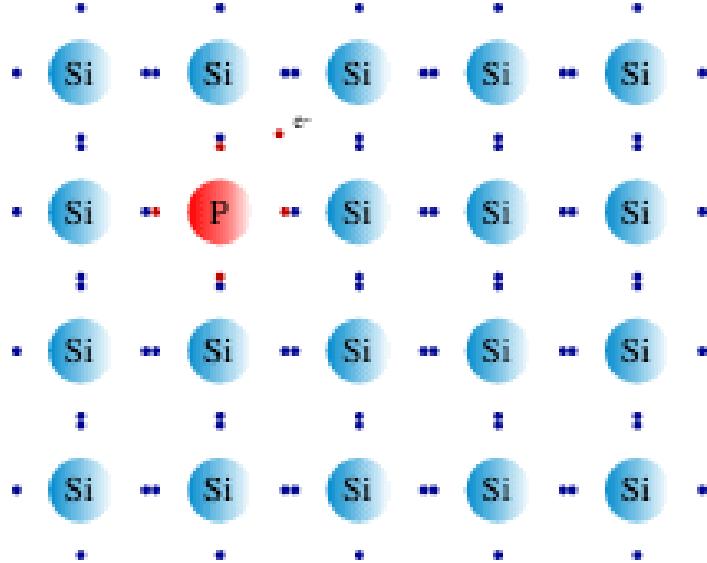


Grundmann 12.3

**Topic of Classes 09-10**

# Impact of **impurities** on the carrier density

**Topic of Class 05**



**INCREASE OF CONDUCTIVITY  
WITH IMPURITIES**